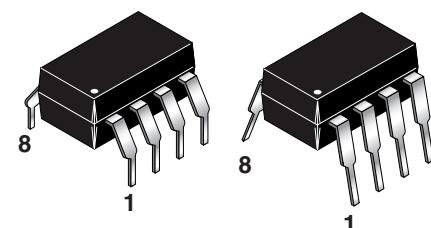
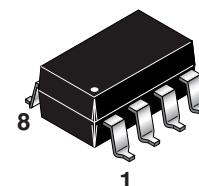


**SINGLE-CHANNEL****6N137****HCPL-2601****HCPL-2611****DUAL-CHANNEL****HCPL-2630****HCPL-2631****DESCRIPTION**

The 6N137, HCPL-2601/2611 single-channel and HCPL-2630/2631 dual-channel optocouplers consist of a 850 nm AlGaAs LED, optically coupled to a very high speed integrated photodetector logic gate with a strobeable output. This output features an open collector, thereby permitting wired OR outputs. The coupled parameters are guaranteed over the temperature range of -40°C to +85°C. A maximum input signal of 5 mA will provide a minimum output sink current of 13 mA (fan out of 8).

An internal noise shield provides superior common mode rejection of typically 10 kV/μs. The HCPL-2601 and HCPL-2631 has a minimum CMR of 5 kV/μs.

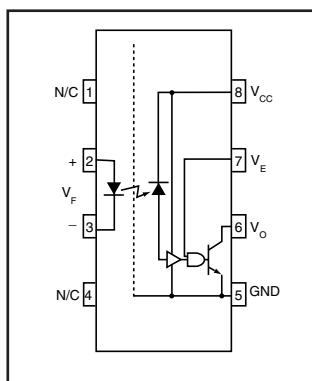
The HCPL-2611 has a minimum CMR of 10 kV/μs.

**FEATURES**

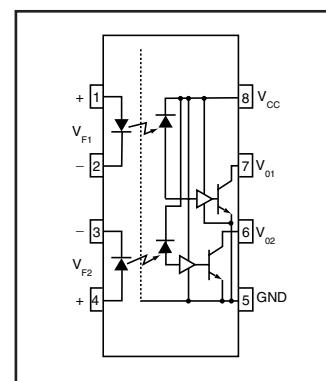
- Very high speed-10 MBit/s
- Superior CMR-10 kV/μs
- Double working voltage-480V
- Fan-out of 8 over -40°C to +85°C
- Logic gate output
- Strobeable output
- Wired OR-open collector
- U.L. recognized (File # E90700)

**APPLICATIONS**

- Ground loop elimination
- LSTTL to TTL, LSTTL or 5-volt CMOS
- Line receiver, data transmission
- Data multiplexing
- Switching power supplies
- Pulse transformer replacement
- Computer-peripheral interface



6N137  
HCPL-2601  
HCPL-2611



HCPL-2630  
HCPL-2631

**TRUTH TABLE**

(Positive Logic)

Input	Enable	Output
H	H	L
L	H	H
H	L	H
L	L	H
H	NC	L
L	NC	H

A 0.1 μF bypass capacitor must be connected between pins 8 and 5.  
(See note 1)

**SINGLE-CHANNEL**

6N137

HCPL-2601

HCPL-2611

**DUAL-CHANNEL**

HCPL-2630

HCPL-2631

**ABSOLUTE MAXIMUM RATINGS** (No derating required up to 85°C)

Parameter	Symbol	Value	Units
Storage Temperature	T <sub>STG</sub>	-55 to +125	°C
Operating Temperature	T <sub>OPR</sub>	-40 to +85	°C
Lead Solder Temperature	T <sub>SOL</sub>	260 for 10 sec	°C
<b>EMITTER</b>			
DC/Average Forward	I <sub>F</sub>	50	mA
Input Current		30	
Enable Input Voltage	V <sub>E</sub>	5.5	V
Not to exceed V <sub>CC</sub> by more than 500 mV			
Reverse Input Voltage	V <sub>R</sub>	5.0	V
Power Dissipation	P <sub>I</sub>	100	mW
Dual channel (Each channel)		45	
<b>DETECTOR</b>			
Supply Voltage	V <sub>CC</sub> (1 minute max)	7.0	V
Output Current	I <sub>O</sub>	50	mA
Dual channel (Each channel)		50	
Output Voltage	V <sub>O</sub>	7.0	V
Collector Output	P <sub>O</sub>	85	mW
Dual channel (Each channel)		60	

**RECOMMENDED OPERATING CONDITIONS**

Parameter	Symbol	Min	Max	Units
Input Current, Low Level	I <sub>FL</sub>	0	250	µA
Input Current, High Level	I <sub>FH</sub>	*6.3	15	mA
Supply Voltage, Output	V <sub>CC</sub>	4.5	5.5	V
Enable Voltage, Low Level	V <sub>EL</sub>	0	0.8	V
Enable Voltage, High Level	V <sub>EH</sub>	2.0	V <sub>CC</sub>	V
Low Level Supply Current	T <sub>A</sub>	-40	+85	°C
Fan Out (TTL load)	N		8	

\* 6.3 mA is a guard banded value which allows for at least 20 % CTR degradation. Initial input current threshold value is 5.0 mA or less

**SINGLE-CHANNEL**

**6N137**

**HCPL-2601**

**HCPL-2611**

**DUAL-CHANNEL**

**HCPL-2630**

**HCPL-2631**

**ELECTRICAL CHARACTERISTICS** ( $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$  Unless otherwise specified.)

**INDIVIDUAL COMPONENT CHARACTERISTICS**

Parameter	Test Conditions	Symbol	Min	Typ**	Max	Unit
<b>EMITTER</b>	( $I_F = 10 \text{ mA}$ ) $T_A = 25^\circ\text{C}$	$V_F$			1.8	
Input Forward Voltage				1.4	1.75	V
Input Reverse Breakdown Voltage	( $I_R = 10 \mu\text{A}$ )	$B_{VR}$	5.0			V
Input Capacitance	( $V_F = 0$ , $f = 1 \text{ MHz}$ )	$C_{IN}$		60		pF
Input Diode Temperature Coefficient	( $I_F = 10 \text{ mA}$ )	$\Delta V_F/\Delta T_A$		-1.4		mV/ $^\circ\text{C}$
<b>DETECTOR</b>						
High Level Supply Current	Single Channel ( $V_{CC} = 5.5 \text{ V}$ , $I_F = 0 \text{ mA}$ ) Dual Channel ( $V_E = 0.5 \text{ V}$ )	$I_{CCH}$		7	10	mA
Low Level Supply Current	Single Channel ( $V_{CC} = 5.5 \text{ V}$ , $I_F = 10 \text{ mA}$ ) Dual Channel ( $V_E = 0.5 \text{ V}$ )	$I_{CCL}$		9	13	mA
Low Level Enable Current	( $V_{CC} = 5.5 \text{ V}$ , $V_E = 0.5 \text{ V}$ )	$I_{EL}$		-0.8	-1.6	mA
High Level Enable Current	( $V_{CC} = 5.5 \text{ V}$ , $V_E = 2.0 \text{ V}$ )	$I_{EH}$		-0.6	-1.6	mA
High Level Enable Voltage	( $V_{CC} = 5.5 \text{ V}$ , $I_F = 10 \text{ mA}$ )	$V_{EH}$	2.0			V
Low Level Enable Voltage	( $V_{CC} = 5.5 \text{ V}$ , $I_F = 10 \text{ mA}$ ) (Note 3)	$V_{EL}$			0.8	V

**SWITCHING CHARACTERISTICS** ( $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$ ,  $V_{CC} = 5 \text{ V}$ ,  $I_F = 7.5 \text{ mA}$  Unless otherwise specified.)

AC Characteristics	Test Conditions	Symbol	Min	Typ**	Max	Unit
Propagation Delay Time to Output High Level	(Note 4) ( $T_A = 25^\circ\text{C}$ ) ( $R_L = 350 \Omega$ , $C_L = 15 \text{ pF}$ ) (Fig. 12)	$T_{PLH}$	20	45	75	ns
					100	
Propagation Delay Time to Output Low Level	(Note 5) ( $T_A = 25^\circ\text{C}$ ) ( $R_L = 350 \Omega$ , $C_L = 15 \text{ pF}$ ) (Fig. 12)	$T_{PHL}$	25	45	75	ns
					100	
Pulse Width Distortion	( $R_L = 350 \Omega$ , $C_L = 15 \text{ pF}$ ) (Fig. 12)	$ T_{PHL}-T_{PLH} $		3	35	ns
Output Rise Time (10-90%)	( $R_L = 350 \Omega$ , $C_L = 15 \text{ pF}$ ) (Note 6) (Fig. 12)	$t_r$		50		ns
Output Fall Time (90-10%)	( $R_L = 350 \Omega$ , $C_L = 15 \text{ pF}$ ) (Note 7) (Fig. 12)	$t_f$		12		ns
Enable Propagation Delay Time to Output High Level	( $I_F = 7.5 \text{ mA}$ , $V_{EH} = 3.5 \text{ V}$ ) ( $R_L = 350 \Omega$ , $C_L = 15 \text{ pF}$ ) (Note 8) (Fig. 13)	$t_{ELH}$		20		ns
Enable Propagation Delay Time to Output Low Level	( $I_F = 7.5 \text{ mA}$ , $V_{EH} = 3.5 \text{ V}$ ) ( $R_L = 350 \Omega$ , $C_L = 15 \text{ pF}$ ) (Note 9) (Fig. 13)	$t_{EHL}$		20		ns
Common Mode Transient Immunity (at Output High Level)	( $T_A = 25^\circ\text{C}$ ) $ V_{CM}  = 50 \text{ V}$ , (Peak) ( $I_F = 0 \text{ mA}$ , $V_{OH}$ (Min.) = 2.0 V)	$ CM_H $				
6N137, HCPL-2630	( $R_L = 350 \Omega$ ) (Note 10)			10,000		V/ $\mu\text{s}$
HCPL-2601, HCPL-2631	(Fig. 14)		5000	10,000		
HCPL-2611	$ V_{CM}  = 400 \text{ V}$		10,000	15,000		
Common Mode Transient Immunity (at Output Low Level)	( $R_L = 350 \Omega$ ) ( $I_F = 7.5 \text{ mA}$ , $V_{OL}$ (Max.) = 0.8 V) 6N137, HCPL-2630	$ CM_L $		10,000		
HCPL-2601, HCPL-2631	$ V_{CM}  = 50 \text{ V}$ (Peak) ( $T_A = 25^\circ\text{C}$ )		5000	10,000		V/ $\mu\text{s}$
HCPL-2611	(Note 11) (Fig. 14)		10,000	15,000		

**SINGLE-CHANNEL**

**6N137**

**HCPL-2601**

**HCPL-2611**

**DUAL-CHANNEL**

**HCPL-2630**

**HCPL-2631**

**TRANSFER CHARACTERISTICS** ( $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$  Unless otherwise specified.)

DC Characteristics	Test Conditions	Symbol	Min	Typ**	Max	Unit
High Level Output Current ( $V_{CC} = 5.5 \text{ V}$ , $V_O = 5.5 \text{ V}$ ) ( $I_F = 250 \mu\text{A}$ , $V_E = 2.0 \text{ V}$ ) (Note 2)		$I_{OH}$			100	$\mu\text{A}$
Low Level Output Current ( $V_{CC} = 5.5 \text{ V}$ , $I_F = 5 \text{ mA}$ ) ( $V_E = 2.0 \text{ V}$ , $I_{OL} = 13 \text{ mA}$ ) (Note 2)		$V_{OL}$		.35	0.6	$\text{V}$
Input Threshold Current ( $V_{CC} = 5.5 \text{ V}$ , $V_O = 0.6 \text{ V}$ , $V_E = 2.0 \text{ V}$ , $I_{OL} = 13 \text{ mA}$ )		$I_{FT}$		3	5	$\text{mA}$

**ISOLATION CHARACTERISTICS** ( $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$  Unless otherwise specified.)

Characteristics	Test Conditions	Symbol	Min	Typ**	Max	Unit
Input-Output (Relative humidity = 45%)						
Insulation Leakage Current ( $T_A = 25^\circ\text{C}$ , $t = 5 \text{ s}$ ) ( $V_{I-O} = 3000 \text{ VDC}$ ) (Note 12)		$I_{I-O}$			1.0*	$\mu\text{A}$
Withstand Insulation Test Voltage (RH < 50%, $T_A = 25^\circ\text{C}$ ) (Note 12) ( $t = 1 \text{ min.}$ )		$V_{ISO}$	2500			$\text{V}_{\text{RMS}}$
Resistance (Input to Output) ( $V_{I-O} = 500 \text{ V}$ ) (Note 12)		$R_{I-O}$		$10^{12}$		$\Omega$
Capacitance (Input to Output) ( $f = 1 \text{ MHz}$ ) (Note 12)		$C_{I-O}$		0.6		$\text{pF}$

\*\* All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^\circ\text{C}$

**NOTES**

1. The  $V_{CC}$  supply to each optoisolator must be bypassed by a  $0.1\mu\text{F}$  capacitor or larger. This can be either a ceramic or solid tantalum capacitor with good high frequency characteristic and should be connected as close as possible to the package  $V_{CC}$  and GND pins of each device.
2. Each channel.
3. Enable Input - No pull up resistor required as the device has an internal pull up resistor.
4.  $t_{PLH}$  - Propagation delay is measured from the 3.75 mA level on the HIGH to LOW transition of the input current pulse to the 1.5 V level on the LOW to HIGH transition of the output voltage pulse.
5.  $t_{PHL}$  - Propagation delay is measured from the 3.75 mA level on the LOW to HIGH transition of the input current pulse to the 1.5 V level on the HIGH to LOW transition of the output voltage pulse.
6.  $t_r$  - Rise time is measured from the 90% to the 10% levels on the LOW to HIGH transition of the output pulse.
7.  $t_f$  - Fall time is measured from the 10% to the 90% levels on the HIGH to LOW transition of the output pulse.
8.  $t_{ELH}$  - Enable input propagation delay is measured from the 1.5 V level on the HIGH to LOW transition of the input voltage pulse to the 1.5 V level on the LOW to HIGH transition of the output voltage pulse.
9.  $t_{EHL}$  - Enable input propagation delay is measured from the 1.5 V level on the LOW to HIGH transition of the input voltage pulse to the 1.5 V level on the HIGH to LOW transition of the output voltage pulse.
10.  $CM_H$  - The maximum tolerable rate of rise of the common mode voltage to ensure the output will remain in the high state (i.e.,  $V_{OUT} > 2.0 \text{ V}$ ). Measured in volts per microsecond ( $\text{V}/\mu\text{s}$ ).
11.  $CM_L$  - The maximum tolerable rate of rise of the common mode voltage to ensure the output will remain in the low output state (i.e.,  $V_{OUT} < 0.8 \text{ V}$ ). Measured in volts per microsecond ( $\text{V}/\mu\text{s}$ ).
12. Device considered a two-terminal device: Pins 1,2,3 and 4 shorted together, and Pins 5,6,7 and 8 shorted together.

**SINGLE-CHANNEL**

**6N137**

**HCPL-2601**

**HCPL-2611**

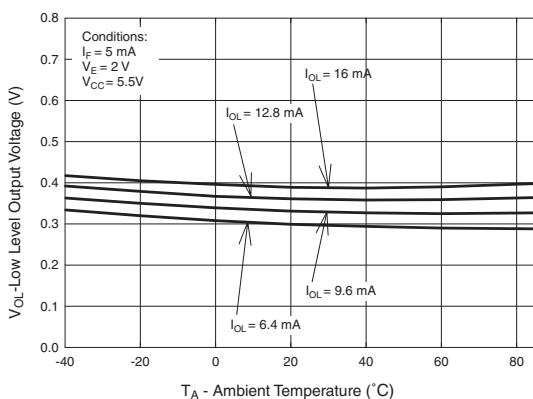
**DUAL-CHANNEL**

**HCPL-2630**

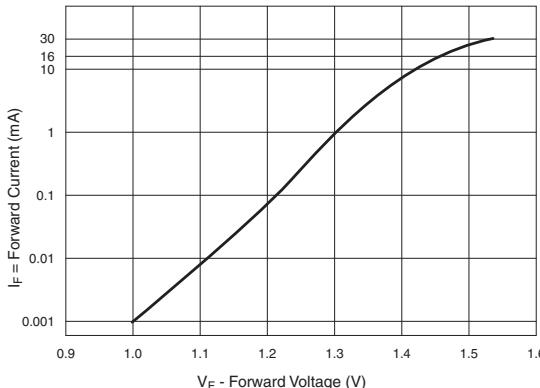
**HCPL-2631**

**TYPICAL PERFORMANCE CURVES**

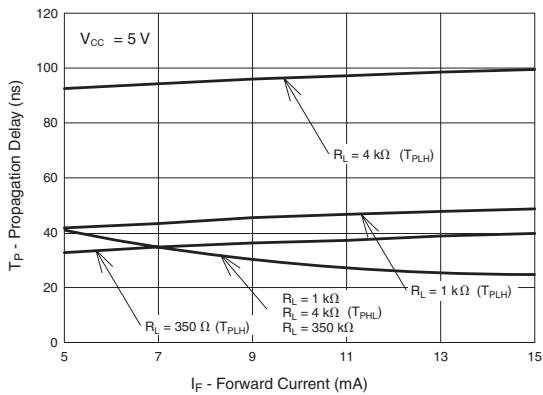
**Fig.1 Low Level Output Voltage vs. Ambient Temperature**



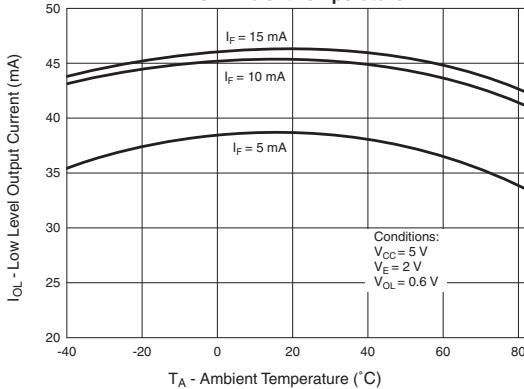
**Fig. 2 Input Diode Forward Voltage vs. Forward Current**



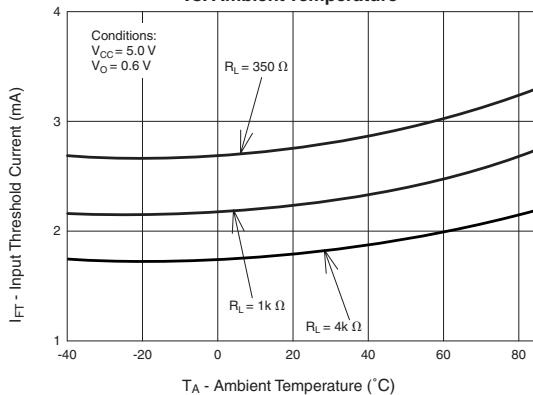
**Fig.3 Switching Time vs. Forward Current**



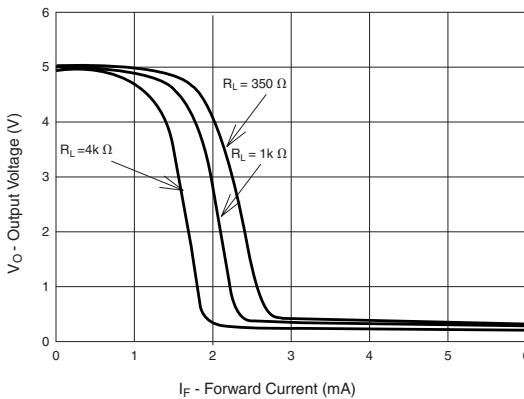
**Fig. 4 Low Level Output Current vs. Ambient Temperature**



**Fig. 5 Input Threshold Current vs. Ambient Temperature**



**Fig. 6 Output Voltage vs. Input Forward Current**



**SINGLE-CHANNEL**

**6N137**

**HCPL-2601**

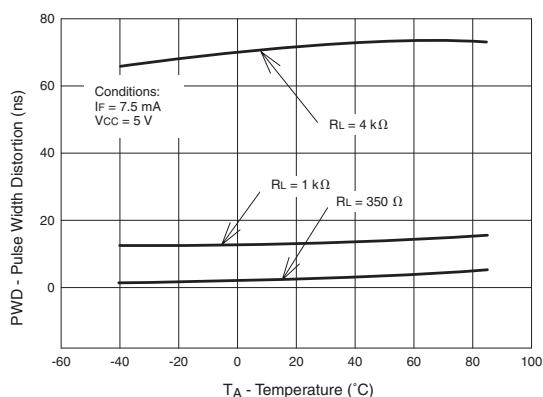
**HCPL-2611**

**DUAL-CHANNEL**

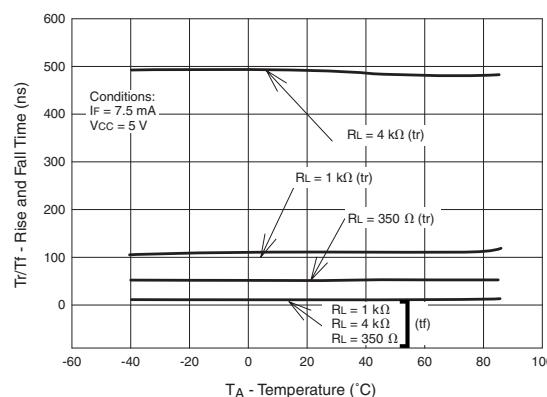
**HCPL-2630**

**HCPL-2631**

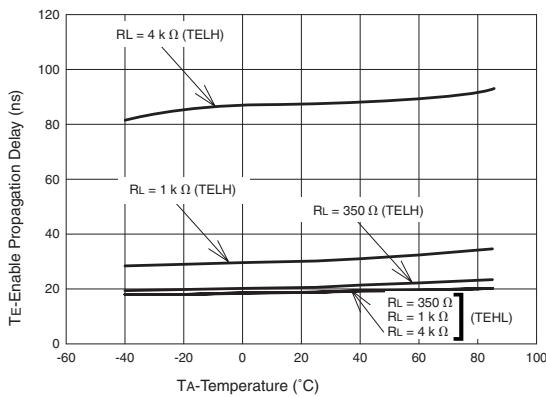
**Fig. 7 Pulse Width Distortion vs. Temperature**



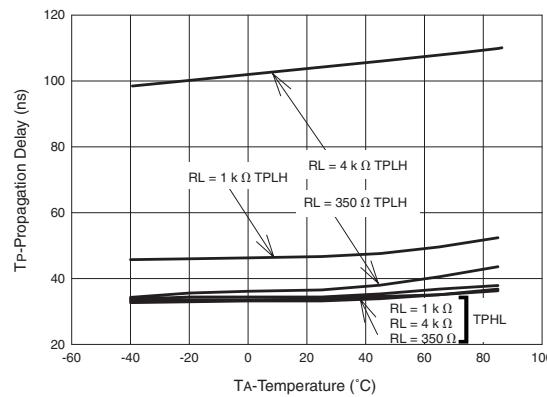
**Fig. 8 Rise and Fall Time vs. Temperature**



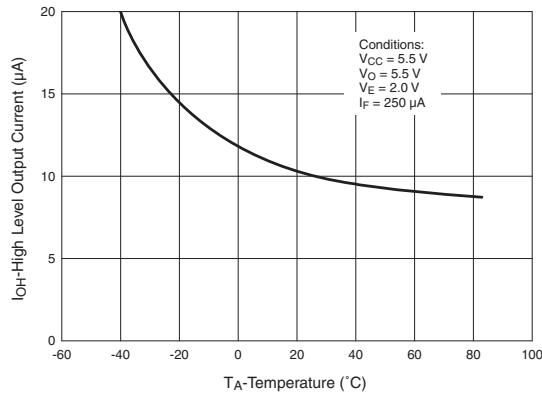
**Fig. 9 Enable Propagation Delay vs. Temperature**



**Fig. 10 Switching Time vs. Temperature**



**Fig. 11 High Level Output Current vs. Temperature**



**SINGLE-CHANNEL**

**6N137**

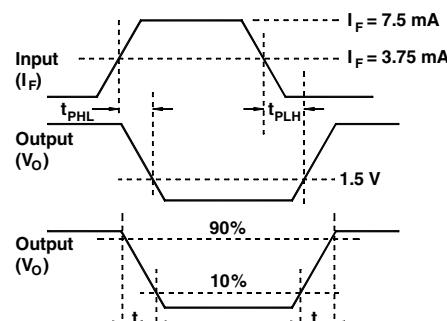
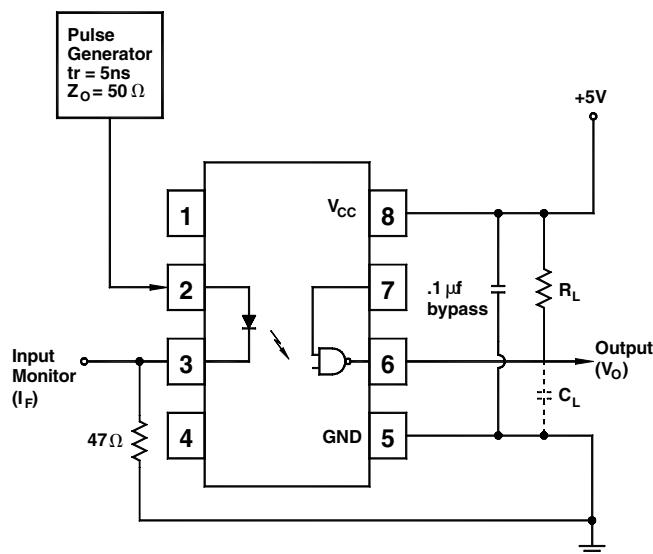
**HCPL-2601**

**HCPL-2611**

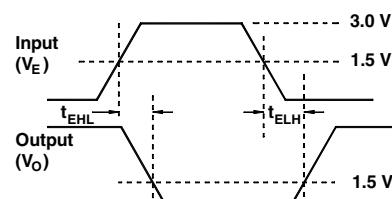
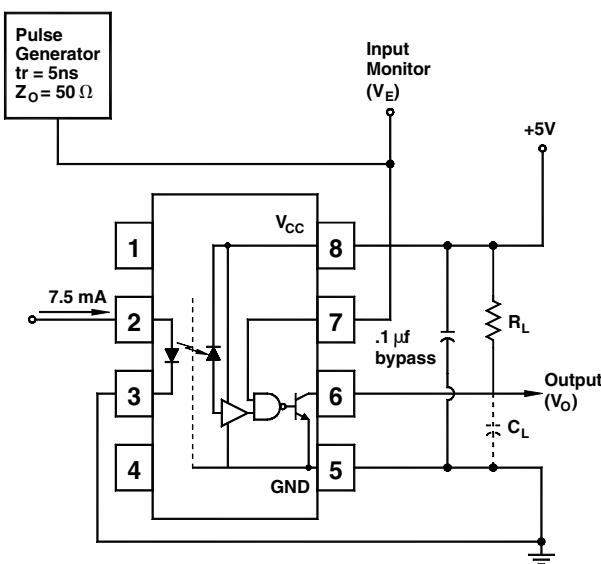
**DUAL-CHANNEL**

**HCPL-2630**

**HCPL-2631**



**Fig. 12 Test Circuit and Waveforms for  $t_{PLH}$ ,  $t_{PHL}$ ,  $t_r$  and  $t_f$ .**



**Fig. 13 Test Circuit  $t_{EHL}$  and  $t_{ELH}$ .**

**SINGLE-CHANNEL**

6N137

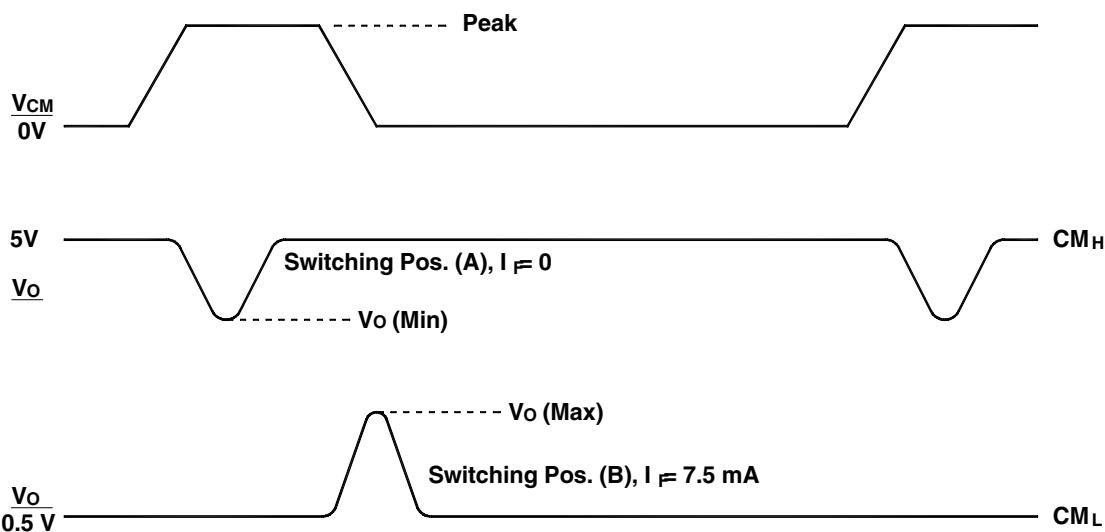
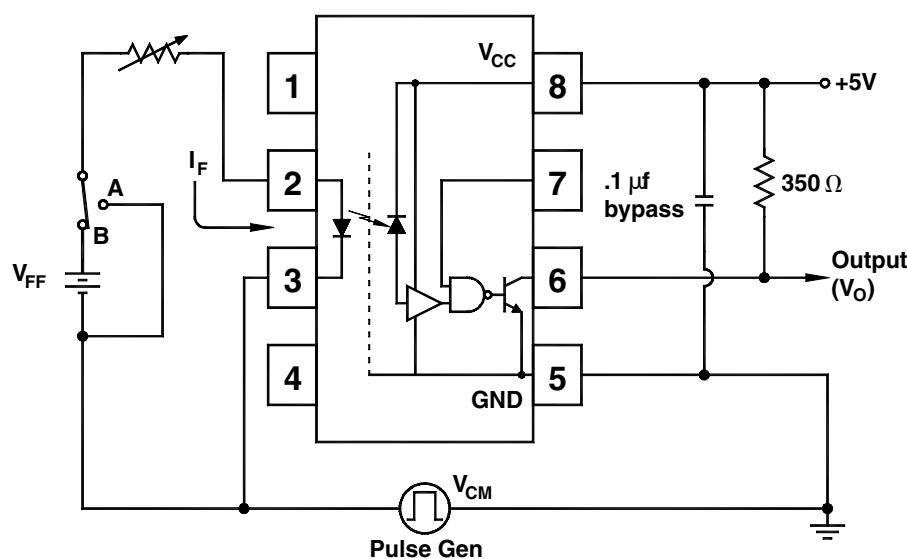
HCPL-2601

HCPL-2611

**DUAL-CHANNEL**

HCPL-2630

HCPL-2631



**Fig. 14 Test Circuit Common Mode Transient Immunity**

**SINGLE-CHANNEL**

**6N137**

**HCPL-2601**

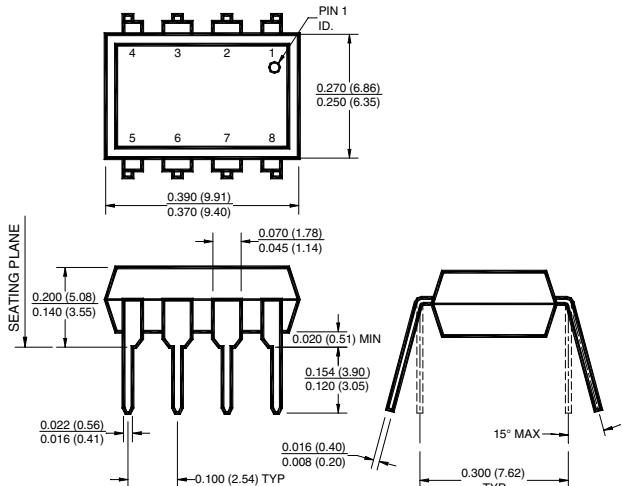
**HCPL-2611**

**DUAL-CHANNEL**

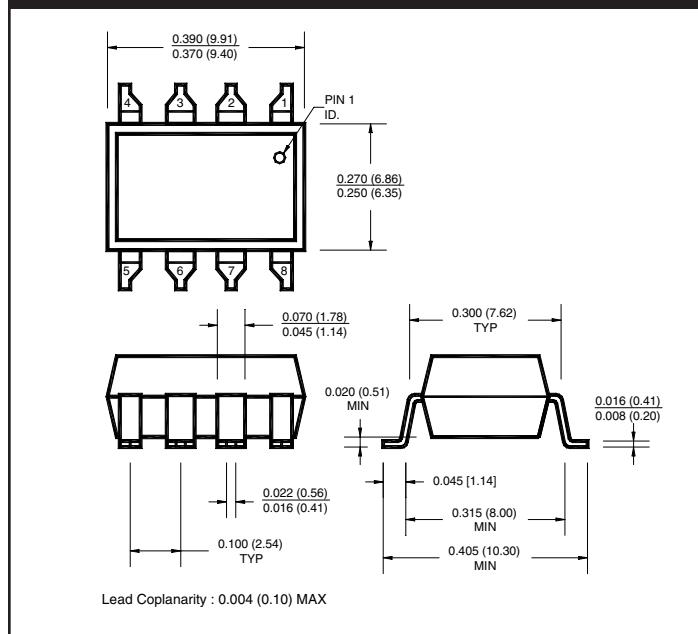
**HCPL-2630**

**HCPL-2631**

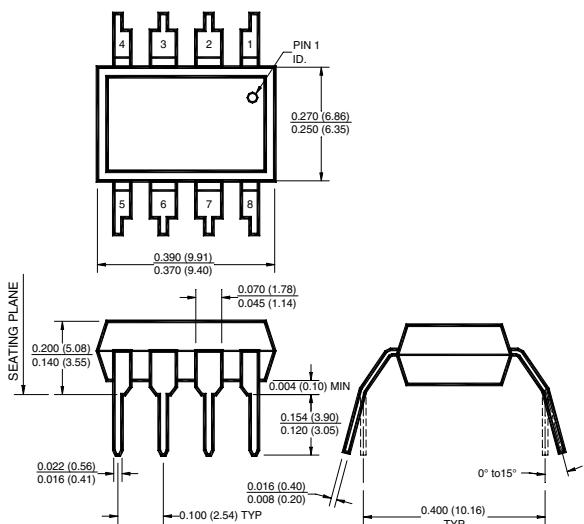
**Package Dimensions (Through Hole)**



**Package Dimensions (Surface Mount)**



**Package Dimensions (0.4" Lead Spacing)**



**NOTE**

All dimensions are in inches (millimeters)

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## SINGLE-CHANNEL

6N137

HCPL-2601

HCPL-2611

DUAL-CHANNEL

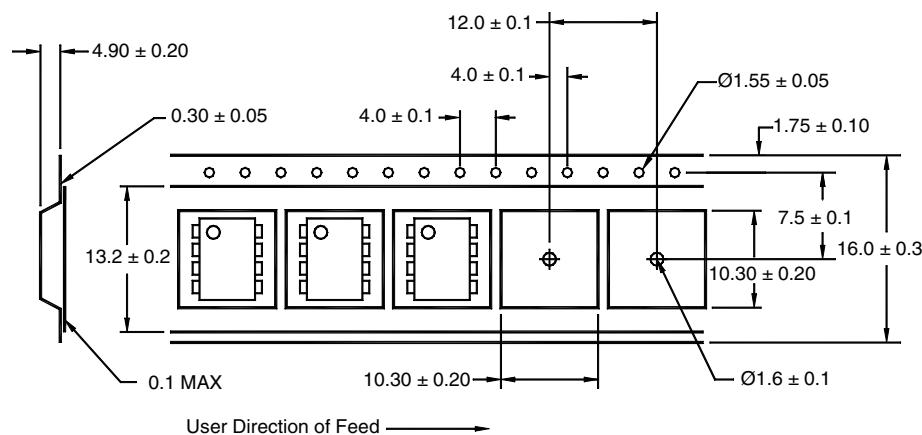
HCPL-2630

HCPL-2631

## **ORDERING INFORMATION**

Option	Order Entry Identifier	Description
S	.S	Surface Mount Lead Bend
SD	.SD	Surface Mount; Tape and reel
W	.W	0.4" Lead Spacing

#### **QT Carrier Tape Specifications (“D” Taping Orientation)**



**SINGLE-CHANNEL**

**6N137**

**HCPL-2601**

**HCPL-2611**

**DUAL-CHANNEL**

**HCPL-2630**

**HCPL-2631**

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2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.